

Semiconductor

STOCK LIST

Dec.

2024year

No.	Maker	Item	Model	Vintage	Configuration	Remark
1	JEOL	FE-EPMA	JXA-8530F	2017	<ul style="list-style-type: none"> •JXA-8530F(5ch) Plus •EPMA Data processor •Phase analysis program •Irregular sample analysis program •Trace element analysis program •Phase map Maker •Liquid nitrogen trap •Chiller •Active Vibration removal stand 	
2	JEOL	SEM	JSM-6510LV	2014	<ul style="list-style-type: none"> •JSM-6510LV •EDS AMETEK EDAX Octane Pro •Operation Keyboard •Motor Controlled Stage(2 Axis) 	
3	JEOL	SEM	JSM-6360LV	2004	<ul style="list-style-type: none"> •JSM-6360LV SEM main unit •EDAX G-XM2 CDU/SUTW •61090(MS) 2-axis motor stage(Max specimen size 150 mm, 80x40mm) •47414 PC unit(2 USB port, PC card slot) •34470 backscatter electron detector •47512 CRT monitor •65020(PRD2) device for photography •65040(CSI2) device for scan Image photography •65150(OKB) operation keyboard •49020 chiller •LGSHL solvent holder 	
4	Keyence	3D Surface Measurement Microscope	VE-9800S	2006	with 3D/Motorized Stage EDAX G-XM2 CDU/SUTW	

5	Olympus	Semiconductor wafer inspection microscope	2006	<ul style="list-style-type: none"> •Brightfield/Darkfield illuminator+Fiber Adapter(BX-RLA2+U-LGAD) •Motorized Nosepiece 6-Position RMS Threads(ob: 1.25x 2.5x 10x 20x 50x 100xBD)(U-D6REM) •Levo Controller/Hand switch(U-REMCB/U-HSTR) •Light Guide •Transmission Light unit •Imaging lens(Camera adapter)/touble port(U-TLU+U-TV0.5XC) •Light Reduction Filter/Color Temperature Conversion Filter •Color camera(Including the manual measurement function) •Stage and stage driving controller •Color video printers and ACC •Auto focus unit and PC 	
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Price is being negotiated (not secured/매입 검토중)

No.	Maker	Item	Model	Vintage	Configuration	Remark
1	Hitachi	SEM	S-3700N	2017	SEM, Large Sample Chamber (maximum 300mm diameter), 5-axis MD, Camera Navigation, Secondary/Reflection Electrons, Low Vacuum Secondary Electron Detector ESED-II, EDX HORIBA EMAX Evolution X Max50 EX470	
2	Hitachi	SEM	SU3500	2016	SEM, Secondary Electron Detector, Reflection Electron Detector, Low Vacuum Secondary Electron Detector, EDX (AMETEC Octane Plus), MC1000 ion Sputter, Etc.	
3	Hitachi	SEM	S-3400N	2011	SEM, Type1, Secondary Electron Detector, Reflection Electron Detector, Maximum Sample Size 200mm×35mm thickness, Turbo-Molecular Pump	
4	JEOL	SEM	JSM-IT200LA	2019	SEM, EDS, Low Vacuum Secondary Electron Detector, Station Navigation, Chamber Scope, Carbon Coater, Freezing/Drying system	Upcoming in 2025
5	JEOL	Desktop SEM	JCM-7000	2020	Desktop SEM, EDS, High/Low Vacuum Mode, X/Y Motor Drive Stage, Stage Navigation, Inclined Rotary Motor Drive Holder	
6	Shimadzu	Microfocus X-Ray CT System	inspe X io SMX225CT FPD HR	2016	FPD-16, 8CL-H, Data processing system, Image analysis S/W, Sub work station, Etc.	
7	Leica	Stereo Microscope	M80	2017	M80, Objective lens Plan 1.0x, LED ring light, Binocular tilt lens barrel 45 degrees, Eyepiece 10x(x2), Ergo wedge, Photo tube, Digital camera MC170HD, C-mount, Flex Arm	

재고리스트 중 견적을 희망하는 장비가 있으시거나, 중고 분석/이화학 장비에 대한 추가적인 문의 사항이 있으신 분들께서는 아래의 이메일/전화를 통해 연락 부탁드립니다.

만약, 찾으시는 장비가 재고 리스트에 없더라도 확인 가능하오니 많은 문의 부탁드립니다.

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